

POWER MOSFET THRU-HOLE (TO-254AA)

60V, N-CHANNEL HEXFET MOSFET TECHNOLOGY

Product Summary

Part Number	R _{DS(on)}	Ι _D	
IRFM044	0.04Ω	35A*	

TO-254AA

Description

HEXFET MOSFET technology is the key to IR HiRel advanced line of power MOSFET transistors. The efficient geometry design achieves very low on-state resistance combined with high trans conductance. HEXFET transistors also feature all of the well-established advantages of MOSFETs, such as voltage control, very fast switching, ease of paralleling and electrical parameter temperature stability. They are well-suited for applications such as switching power supplies, motor controls, inverters, choppers, audio amplifiers, high energy pulse circuits, and virtually any application where high reliability is required. The HEXFET transistor's totally isolated package eliminates the need for additional isolating material between the device and the heat sink. This improves thermal efficiency and reduces drain capacitance.

Features

- Simple Drive Requirements
- Hermetically Sealed
- Electrically Isolated
- Dynamic dv/dt Rating
- Light Weight

Absolute Maximum Ratings

Symbol	Parameter	Value	Units
I _{D1} @ V _{GS} = 10V, T _C = 25°C	Continuous Drain Current	35*	
I _{D2} @ V _{GS} = 10V, T _C = 100°C	Continuous Drain Current	28	Α
I _{DM}	Pulsed Drain Current ①	180	
P _D @T _C = 25°C	Maximum Power Dissipation	125	W
	Linear Derating Factor	1.0	W/°C
V _{GS}	Gate-to-Source Voltage	± 20	V
E _{AS}	Single Pulse Avalanche Energy ②	340	mJ
I _{AR}	Avalanche Current ①	35	Α
E _{AR}	Repetitive Avalanche Energy ①	12.5	mJ
dv/dt	Peak Diode Recovery dv/dt ③	4.5	V/ns
T _J	Operating Junction and	-55 to + 150	
T _{STG}	Storage Temperature Range		°C
	Lead Temperature	300 (0.063 in. /1.6 mm from case for	
	Weight	9.3 (Typical)	g

^{*} Current is limited by package For Footnotes refer to the page 2.



Electrical Characteristics @ T_j = 25°C (Unless Otherwise Specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
BV _{DSS}	Drain-to-Source Breakdown Voltage	60			V	$V_{GS} = 0V, I_{D} = 1.0mA$
$\Delta BV_{DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.68		V/°C	Reference to 25°C, I _D = 1.0mA
D	Static Drain-to-Source On-State			0.04	Ω	V _{GS} = 10V, I _{D2} = 28A ④
$R_{DS(on)}$	Resistance			0.05	2.2	V _{GS} = 10V, I _{D1} = 35A ④
$V_{GS(th)}$	Gate Threshold Voltage	2.0		4.0	V	$V_{DS} = V_{GS}$, $I_D = 250\mu A$
Gfs	Forward Transconductance	17			S	V _{DS} = 15V, I _D = 28A ④
I _{DSS}	Zero Gate Voltage Drain Current			25		$V_{DS} = 48V$, $V_{GS} = 0V$
				250	μA	$V_{DS} = 48V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I _{GSS}	Gate-to-Source Leakage Forward			100	nA	$V_{GS} = 20V$
	Gate-to-Source Leakage Reverse			-100	11/1	$V_{GS} = -20V$
Q_G	Total Gate Charge			88		$I_{D1} = 35A$
Q_{GS}	Gate-to-Source Charge			15	nC	V _{DS} = 30V
Q_{GD}	Gate-to-Drain ('Miller') Charge			52		V _{GS} = 10V
t _{d(on)}	Turn-On Delay Time			23		$V_{DD} = 30V$
tr	Rise Time			130	no	I _{D1} = 35A
$t_{d(off)}$	Turn-Off Delay Time			81	ns	$R_G = 9.1\Omega$
t _f	Fall Time			79		V _{GS} = 10V
Ls +L _D	Total Inductance		6.8		nH	Measured from Drain lead (6mm / 0.25 in from package) to Source lead (6mm/0.25 in from package) with Source wire internally bonded from Source pin to Drain pad
C _{iss}	Input Capacitance		2400			V _{GS} = 0V
C _{oss}	Output Capacitance		1100		pF	V _{DS} = 25V
C _{rss}	Reverse Transfer Capacitance		230			f = 1.0MHz

Source-Drain Diode Ratings and Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
Is	Continuous Source Current (Body Diode)			35*	۸	
I _{SM}	Pulsed Source Current (Body Diode) ①			180	Α	
V_{SD}	Diode Forward Voltage			2.5	V	$T_J = 25^{\circ}C, I_S = 35A, V_{GS} = 0V$
t _{rr}	Reverse Recovery Time			220	ns	$T_J = 25^{\circ}C, I_F = 35A, V_{DD} \le 50V$
Q _{rr}	Reverse Recovery Charge			1.6	μC	di/dt = 100A/µs ④
t _{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by $L_{\text{S}}\text{+}L_{\text{D}})$				

^{*} Current is limited by package

Thermal Resistance

Symbol	Parameter	Min.	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case			1.0	
$R_{\theta CS}$	Case -to-Sink		0.21		°C/W
$R_{\theta JA}$	Junction-to-Ambient (Typical socket mount)			48	

Footnotes:

- ① Repetitive Rating; Pulse width limited by maximum junction temperature.
- $\,$ $\!\!$ V $_{DD}$ = 25V, starting T $_{\!J}$ = 25°C, L = 0.5mH, Peak I $_{\!L}$ = 35A, V $_{\!GS}$ = 10V
- $\label{eq:local_sd} \ensuremath{\Im} \quad I_{SD} \leq 35A, \ di/dt \leq 100A/\mu s, \ V_{DD} \leq 60V, \ T_J \leq 150^{\circ}C$
- 4 Pulse width \leq 300 µs; Duty Cycle \leq 2%.



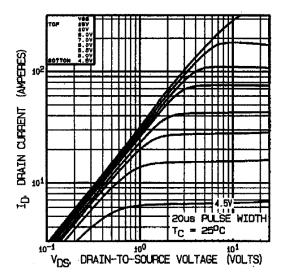


Fig 1. Typical Output Characteristics

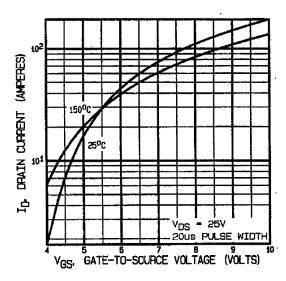


Fig 3. Typical Transfer Characteristics

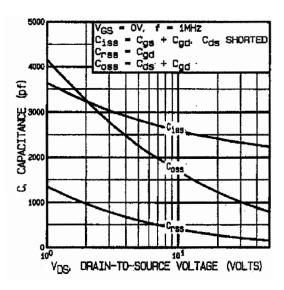


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

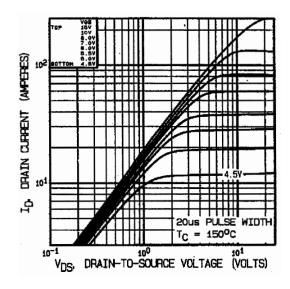


Fig 2. Typical Output Characteristics

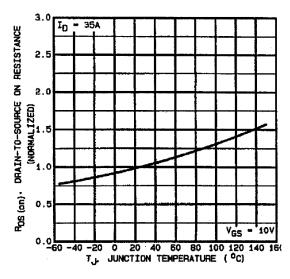


Fig 4. Normalized On-Resistance Vs. Temperature

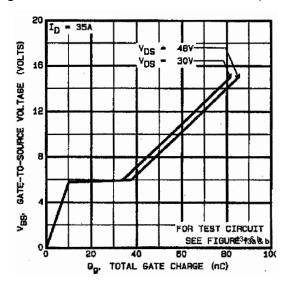


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

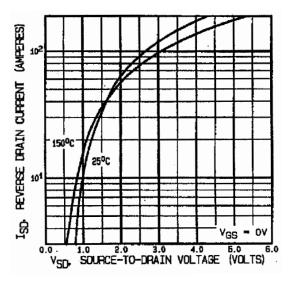


Fig 7. Typical Source-Drain Diode Forward Voltage

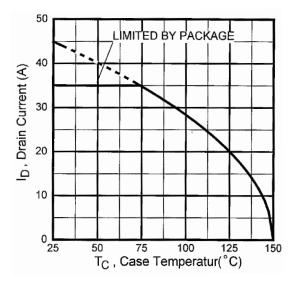


Fig 9. Maximum Drain Current Vs. Case Temperature

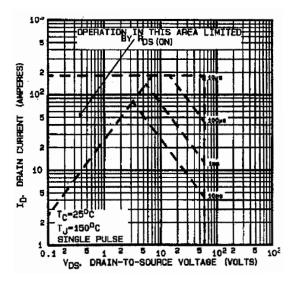


Fig 8. Maximum Safe Operating Area

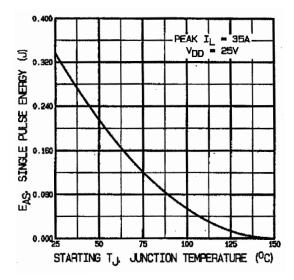


Fig 10. Maximum Avalanche Energy Vs. Drain Current

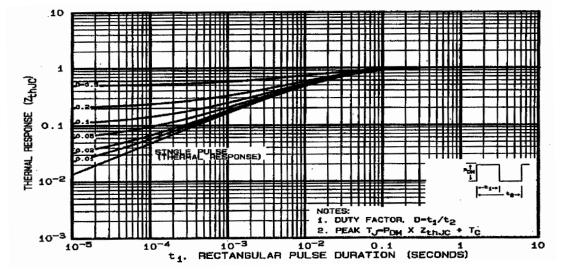


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

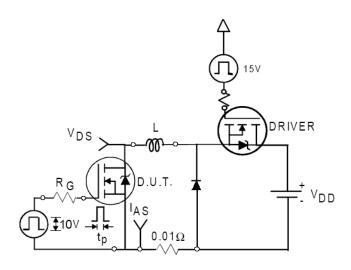


Fig 12a. Unclamped Inductive Test Circuit

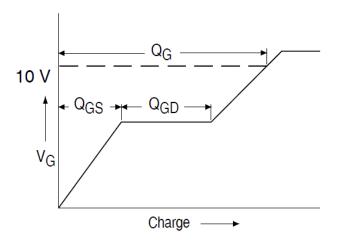


Fig 13a. Basic Gate Charge Waveform

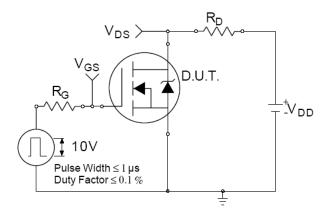


Fig 14a. Switching Time Test Circuit

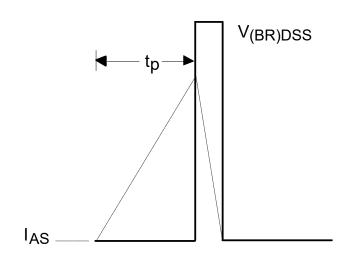


Fig 12b. Unclamped Inductive Waveforms

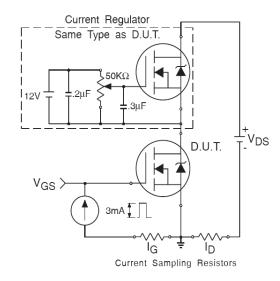


Fig 13b. Gate Charge Test Circuit

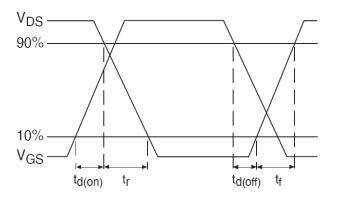
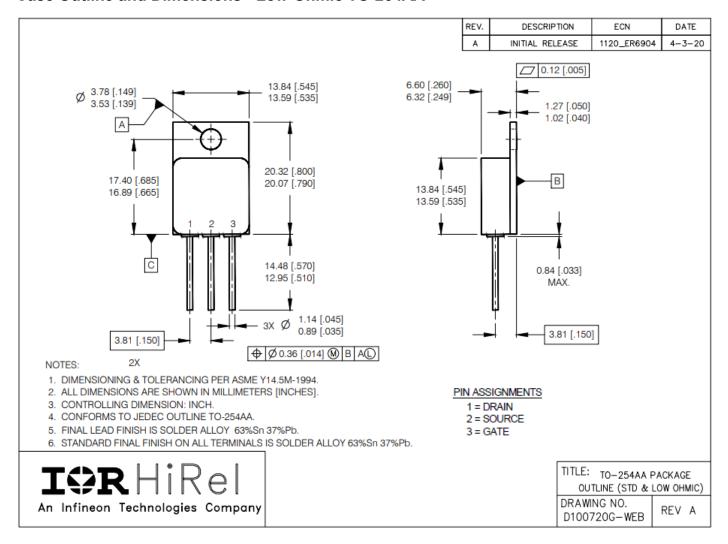


Fig 14b. Switching Time Waveforms



Note: For the most updated package outline, please see the website: TO-254AA

Case Outline and Dimensions - Low-Ohmic TO-254AA



BERYLLIA WARNING PER MIL-PRF-19500

Package containing beryllia shall not be ground, sandblasted, machined, or have other operations performed on them which will produce beryllia or beryllium dust. Furthermore, beryllium oxide packages shall not be placed in acids that will produce fumes containing beryllium.



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Data and specifications subject to change without notice.



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